


<b>Search Notes</b>  	<b>Application/Control No.</b>  10574468	<b>Applicant(s)/Patent Under Reexamination</b>  MIURA ET AL.
	<b>Examiner</b>  DEREK S CHAPEL	<b>Art Unit</b>  2872

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted with Arnel Lavarias about the case	4/10/2008	DSC
EAST Class/Subclass Search: 359/1, 3, 10, 15, 28, 30, 32, 34-35, 900 (text only)	4/9/2008	DSC
EAST text search	4/9/2008	DSC
EAST Class/Subclass Search: 369/93-94, 99, 103, 272.1, 275.1-275.2 (text only, see attached)	11/25/2008	DSC
EAST Update Search	11/25/2008	DSC
Consulted with Arnel Lavarias about the rejections.	11/25/2008	DSC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	Interference Search, see .clm. search	4/11/2008	DSC
	Updated Interference Search, see .clm. search attached	11/25/2008	DSC

/D. S. C. /  
Examiner, Art Unit 2872